## RESEARCH ARTICLE

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# High Field Electron Mobility In Gaas In Comparison With Gasb

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#### Abstract

Electron transport properties in GaSb and GaAs are calculated for different temperature, doping dependencies at high electric field applications. The calculations are performed using a three valleys ensemble Monte Carlo model that includes numerical formulations of the phonon scattering rates and ionized impurity scattering rates. For two materials, we find that electron velocity overshoot only occurs when the electric field in increased to a value above a certain critical field .This critical field is strongly dependent on the material parameters. Results from the two materials are finally compared. The agreement with the available experimental data is found to be satisfactory.

**Keywords-:** *Monte Carlo method; ionized impurity scattering; overshoot velocity.* 

#### I. INTRODUCTION

GaSb and GaAs semiconductors are becoming of increasing importance in many emerging optoelectronic and electronic device applications. Among these applications are ultraviolet photodetectors, blue and UV light emitters, and high frequency, high power electronic devices. As an aid to the device-related work, the transport coefficients of the materials need careful investigation. Transport properties of electrons in GaSb and GaN semiconductors can be conveniently derived by direct solution of the Boltzmann equation [1]. Previous applications of this technique were directed toward calculations of drift mobility in ideally pure semiconductors. There is also considerable interest in accurate descriptions of impure crystals, from both the experimental and the theoretical points of view. In the former case, foe example, one may take advantage of the sensitivity of mobility to ionized impurities in analyses of impurity content. In the latter case, highly doped materials allow one to probe regions of the conduction band in the neighborhood of the Fermi level, well above the band edge. Obviously, accurate calculations in conjunction with experimental data are helpful in exposing weaknesses of the theoretical model, particularly with regard to electron scattering by ionized impurities at low temperatures [2]. The purpose of the present paper is to calculate electron drift velocity for various temperatures and ionized-impurity concentrations. The formulation itself applies only to the central  $\Gamma$ valley conduction band and the two nearest valleys. We have also consider band nonparabolicity, admixture of p-type valence-band wave functions, degeneracy of the electron distribution to any arbitrary degree, and the screening effects of free carriers on the scattering probabilities [3]. All the relevant scattering mechanisms, including the twomode nature of the polar optic phonon scattering, are taken into account [4].

In this communication, we present Monte Carlo calculations of steady-state electron transport conditions in GaSb and GaAs [5]. We demonstrate the effect of injection energy and electric field on the electron transport properties.

This paper is organized as follows. Details of the employed simulation model is presented in section 2 and the results of steady-state electron transport properties carried out on GaSb and GaAs structures are interpreted in section 3.

wavelength optical direction. Another advantage of GaSb is that it provides for type II band alignment in super lattices and quantum wells when used in conjunction with the InAs system. Such structures are being recognized as promising candidates for midinfrared lasers due to the inherent suppression of internal electron-hole recombination. The Auger rates have also been shown to be greatly reduced in the GaSb based super lattices [18-19]. Furthermore, as the GaSb/InAs share no common cation or anion, one can fabricate either an InSb-like or a GaAs-like interface simply by changing the growth sequence. Different vibrational properties are expected to result [20], and the electronic properties of the confined carrier gas are correspondingly affected.

### II. MODEL DETAILS

In order to calculate the electron drift velocity for large electric fields, consideration of conduction band satellite valleys is necessary. The first-principles band structure of zincblende GaSb and GaAs predicts a direct band gap located at the  $\Gamma$  point and lowest energy conduction band satellite valleys at the X point and at the L point. In our Monte Carlo simulation, the  $\Gamma$  valley, the three equivalent X valleys, the four equivalent L valleys, are represented by ellipsoidal, nonparabolic dispersion relationships of the following form [6],

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$$E(k)[1 + \alpha_i E(k)] = \frac{\hbar^2 k^2}{2m^*}$$
 (1)

where m\* is effective mass at the band edge and αi is the non-parabolicity coefficient of the i-th valley. Scattering mechanisms included in the simulation are acoustic deformation potential scattering (treated either as an elastic process or as an inelastic process) and pizoelectric scattering (which is found to be negligible in the temperature range discussed here). Furthermore, longitudinal optical phonon scattering, nonequivalent and, where applicable, equivalent intervalley scattering events are taken into account among all valley types with the transfers assumed to be governed by the same deformation potential fields and the same phonon frequencies. Degeneracy effects are expected to be negligible over almostall of the temperature and electron concentration ranges of interest here and, hence, are not considered in the calculation. In our model at the start of each simulation, ten thousand electron particles are distributed in momentum space according to a Maxwell-Boltzmann distribution function. These particles are propagated classically between collisions according to their velocity, effective mass and the prevailing field. The selection of the propagation time, scattering mechanism and other related quantities is achieved by generating random numbers and using this numbers to select, for example, a scattering mechanism. In the case of the ellipsoidal, nonparabolic conduction valley model, the usual Herring-Vogt transformation matrices are used to map carrier momenta into spherical valleys when particles are drifted or scattered. Steady-state results of high field transport studies have been obtained for lattice temperatures up to 600 K, in order to gain some insight into the hot carrier transport and the energy distribution function that would be generated in the gate-drain region of a power field effect transistor.

## III. RESULTS

Electron drift velocity as a function of electric field is important in determining the performance of high-speed and microwave semiconductor devices. Here we show the results of temperature dependence of the steady-state velocity-field characteristics and valley occupancy in bulk GaSb and GaAs materials.

Figure 1 shows the simulated velocity-field characteristics at 300 K, with a background doping concentration of 10<sup>17</sup> cm<sup>-3</sup>, and with the electric field applied along one of the cubic axes.

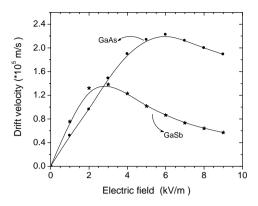


Fig 1. Calculated steady-state electron drift velocity in bulk zincblende GaSb and GaAs using non-parabolic band models.

Similar to the experimental results the simulations suggest that the peak drift velocity for zincblende GaAs is ~2.2×10<sup>5</sup> ms<sup>-1</sup> while that for GaSb is about 1.2×10<sup>5</sup> ms<sup>-1</sup>. At higher electric fields, intervalley optical phonon emission dominates, causing the drift velocity to saturate at around  $0.7 \times 10^5$  $\text{ms}^{-1}$  for GaSb and  $1.7 \times 10^5$   $\text{ms}^{-1}$  for GaAs. The calculated high field electron drift velocity apparent from figure 1 is fractionally lower than those that have been simulated by experimental works which assumed an effective mass in the upper valleys equal to the free electron mass. The threshold field for the onset of significant scattering into satellite conduction band valleys is a function of the intervalley separation and the density of electronic states in the satellite valleys. The importance of electron intervalley transfer at high electric fields can be clearly seen in figure 2. In this figure the fractional valley occupancies for different materials is plotted. It is obvious that the inclusion of satellite valleys in the simulations is important. Significant electron transfer to the upper valleys only begins to occur when the field strength is very close to the threshold value. At the threshold field the electron valley occupancies at room temperature for  $\Gamma$ , L and X are about %85, %13 and %2, respectively.

Figure 3 shows the calculated electron drift velocity as a function of electric field strength for temperatures of 300, 450 and 600 K.

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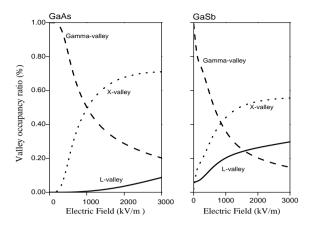


Fig 2. Fractional occupation of the central and satellite valleys in GaSb and GaAs as a function of applied electric field using the non-parabolic band model

The decrease in drift mobility with temperature at low fields is due to increased intravalley polar optical phonon scattering whereas the decrease in velocity at higher fields is due to increased intra and intervalley scattering. It can be seen from the figure that the peak velocity also decreases and moves to higher electric field as the temperature is increased. This is due to the general increase of total scattering rate with temperature, which suppresses the electron energy and reduces the population of the satellite valleys. This latter effect is apparent from the fact that the electron population in the central  $\Gamma$ -valley increases with temperature as shown in figure 2.

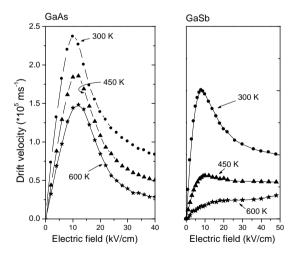


Fig 3. Calculated electron steady-state drift velocity in bulk GaAs and GaSb as a function of applied electric field at various lattice temperatures and assuming a donor concentration of 10<sup>17</sup> cm<sup>-3</sup>. The peak drift velocity decreases while the threshold field increases by same percent as the lattice temperature increases from 300 to 600 K.

Figure 4 shows how the electron occupancy ratios changes with temperature for electrons in the most populated  $\Gamma$  and L valleys. There are significant statistical fluctuations in the results for the electrons in the L valleys for fields around 500 kVm<sup>-1</sup>, which are caused by the relatively small number of electron particles occupying the valleys just above the threshold for intervalley transfer. Nevertheless it can be seen that the number of electrons decreases as the temperature increases for both valleys. Comparison of the temperature dependence of the valleys occupancy in GaAs and GaSb materials show that the change in peak velocity of GaAs from 300 K to 600 K is a reduction of about %45 whereas for GaSb it is about %25. The reason can be explained in terms of the energy band structure. In particular, the different electron effective mass within the central valley. This is important because electrons which are near a valley minimum have small kinetic energies and are therefore strongly scattered. It is apparent that intervalley transfer is substantially larger in InAs over the range of applied electric fields shown, due to the combined effect of a lower  $\Gamma$  effective mass, lower satellite valley separation energy, and slightly lower phonon scattering rate within the  $\Gamma$  valley.

Therefore, the electron velocity in GaAs is less sensitive to temperature than in GaSb, so GaAs devices are expected be more tolerant to self-heating and high ambient temperature.

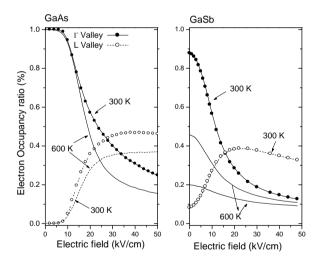


Fig 4. Temperature dependence of the valley occupancy in the  $\Gamma$  and L valleys of GaAs and GaSb materials as a function of applied electric field.

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